

CoolSiC™ 1200V SiC Trench MOSFET Silicon Carbide MOSFET

Features

- Very low switching losses
- Threshold-free on state characteristic
- Wide gate-source voltage range
- Benchmark gate threshold voltage, V_{GS(th)} = 4.5V
- 0V turn-off gate voltage
- Fully controllable dv/dt
- Commutation robust body diode, ready for synchronous rectification
- Easy to use/drive due to sense (driver) source pin for better control of the gate
- Temperature independent turn-off switching losses

Benefits

- Efficiency improvement
- Enabling higher frequency
- Increased power density
- Cooling effort reduction
- Reduction of system complexity and cost

Potential applications

- Energy generation
 - o Solar string inverter and solar optimizer
- Industrial power supplies
 - Industrial UPS
 - Industrial SMPS
- Infrastructure Charge
 - o Charger

Gate pin 4 Sense pin 3 Source pin 2











Product validation

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

Note: the source and sense pins are not exchangeable, their exchange might lead to malfunction

Table 1 Key Performance and Package Parameters

Туре	V _{DS}	I_D $(T_C = 25^{\circ}C, R_{th(j-c,max)})$	$R_{DS(on)}$ ($T_{Vj} = 25^{\circ}\text{C}, I_D = 20\text{A}, V_{GS} = 15\text{V}$)	$T_{j,max}$	Marking	Package
IMZ120R045M1	1200V	52A	45mΩ	175°C	120M1045	PG-TO247-4

CoolSiC™ 1200V SiC Trench MOSFET



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Maximum ratings

1 Maximum ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Symbol	Value	Unit
Drain-source voltage, $T_{vj} \ge 25^{\circ}\text{C}$	$V_{ extsf{DSS}}$	1200	V
DC drain current for $R_{\text{th(j-c,max)}}$, limited by T_{vjmax} , $V_{\text{GS}} = 15V_{\text{g}}$,		
$T_{\rm C} = 25^{\circ}{\rm C}$	I _D	52	А
$T_{C} = 100$ °C		36	
Pulsed drain current, t_p limited by T_{vjmax} , $V_{GS} = 15V$	I _{D,pulse} ¹	130	А
DC body diode forward current for $R_{\text{th(j-c,max)}}$,			
limited by T_{vjmax} , $V_{\text{GS}} = 0\text{V}$	I_{SD}		A
$T_c = 25$ °C	120	52	
$T_{C} = 100$ °C		28	
Pulsed body diode current, $t_{\rm p}$ limited by $T_{\rm vjmax}$	I _{SD,pulse} ¹	130	А
Gate-source voltage ²			
Max transient voltage, < 1% duty cycle	V_{GSS}	-10 20	V
Recommend turn-on gate voltage	$V_{GSS,on}$	15	V
Recommend turn-off gate voltage	$V_{GSS,off}$	0	
Short-circuit withstand time			
$V_{\rm DD} = 800 \text{V}, V_{\rm DS,peak} < 1200 \text{V}, V_{\rm GS,on} = 15 \text{V}, T_{\rm j,start} = 25^{\circ} \text{C}$	t_{SC}	3	μs
Power dissipation, limited by T_{vjmax}			
$T_{C} = 25^{\circ}C$	P _{tot}	228	W
$T_{C} = 100$ °C		114	
Virtual junction temperature	$T_{ m vj}$	-55175	°C
Storage temperature	\mathcal{T}_{stg}	-55 150	°C
Soldering temperature,			
wavesoldering only allowed at leads,	T_{sold}	260	°C
1.6mm (0.063 in.) from case for 10 s			
Mounting torque, M3 screw	A4	0.6	Nine
Maximum of mounting processes: 3	M	0.0	Nm

¹ verified by design

² **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in <u>Application Note AN2018-09</u> must be considered to ensure sound operation of the device over the planned lifetime.

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Thermal resistances

2 Thermal resistances

Table 3

Davamatav	Symbol	Conditions	Value			Unit
Parameter	arameter Symbol	Conditions	min.	typ.	max.	
MOSFET/body diode thermal resistance, junction – case	$R_{th(j-c)}$		-	0.51	0.66	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	leaded	-	-	62	K/W



Electrical Characteristics

3 Electrical Characteristics

3.1 Static characteristics

Table 4 Static characteristics (at T_{vj} = 25°C, unless otherwise specified)

Parameter	Symbol	Symbol Conditions		Value		
			min.	typ.	max.	
Drain-source on-state	$R_{DS(on)}$	$V_{GS} = 15V, I_D = 20A,$				mΩ
resistance		$T_{\rm vj} = 25^{\circ} \rm C$	-	45	59	
		$T_{\rm vj} = 100^{\circ}{\rm C}$	-	55	-	
		$T_{\rm vj} = 175^{\circ}{\rm C}$	-	75	-	
Body diode forward	V_{SD}	$V_{GS} = 0V$, $I_{SD} = 20A$				V
voltage		$T_{\rm vj} = 25^{\circ} C$	-	4.1	5.2	
		$T_{\rm vj} = 100^{\circ}{\rm C}$	-	4.0	-	
		$T_{\rm vj} = 175^{\circ}{\rm C}$	-	3.9	-	
Gate-source threshold	$V_{GS(th)}$	(tested after 1 ms pulse at				V
voltage		$V_{\rm GS} = 20V$				
		$I_{\rm D} = 10 {\rm mA}, V_{\rm DS} = V_{\rm GS}$				
		$T_{\rm vj} = 25^{\circ} C$	3.5	4.5	5.7	
		T _{vj} =175°C	-	3.6	-	
Zero gate voltage drain	I_{DSS}	$V_{\rm GS} = 0$ V, $V_{\rm DS} = 1200$ V				μΑ
current		T _{vj} =25°C	-	2	200	
		<i>T</i> _{vj} =175°C	-	4	-	
Gate-source leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0V$	-	-	120	nA
current		$V_{GS} = -10V, V_{DS} = 0V$	-	-	-120	nA
Transconductance	g_{fs}	$V_{\rm DS} = 20 \text{V}, I_{\rm D} = 20 \text{A}$	-	11.1		S
Internal gate resistance	$R_{G,int}$	$f = 1$ MHz, $V_{AC} = 25$ mV	-	4	-	Ω

CoolSiC™ 1200V SiC Trench MOSFET



Electrical Characteristics

3.2 Dynamic characteristics

Table 5 Dynamic characteristics (at $T_{vj} = 25^{\circ}\text{C}$, unless otherwise specified)

Davamatav	Cumbal	Conditions	Value			11:4
Parameter	Symbol		min.	typ.	max.	Unit
Input capacitance	C _{iss}		-	1900	-	
Output capacitance	Coss	$V_{DD} = 800V, V_{GS} = 0V,$ $f = 1MHz, V_{AC} = 25mV$	-	115	-	pF
Reverse capacitance	C_{rss}		-	13	-	
Coss stored energy	E _{oss}		-	44	-	μJ
Total gate charge	Q _G	$V_{DD} = 800\text{V}, I_{D} = 20\text{A},$ $V_{GS} = 0/15\text{V}, \text{turn-on pulse}$	-	52	-	
Gate to source charge	$Q_{GS,pl}$		-	15	-	nC
Gate to drain charge	Q_{GD}	$V_{GS} = 0/15v$, turn-on pulse	-	13	-	



Electrical Characteristics

3.3 Switching characteristics

Table 6 Switching characteristics, Inductive load 4

Parameter	Symbol	Symbol Conditions	Value			Unit
			min.	typ.	max.	
MOSFET Characteristics,	<i>T</i> _{νj} = 25°C			·	·	
Turn-on delay time	$t_{\sf d(on)}$	$V_{DD} = 800V, I_{D} = 20A,$	-	9	-	
Rise time	t _r	$V_{\rm GS} = 0/15 \text{V}, R_{\rm G,ext} = 2\Omega,$	-	18	-	
Turn-off delay time	$t_{\sf d(off)}$	L_{σ} = 40nH,	-	17	-	ns
Fall time	t_{f}	diode:	-	13	-	
Turn-on energy	Eon	body diode at $V_{GS} = 0V$ see Fig. E	-	280	-	μJ
Turn-off energy	$E_{ m off}$		-	70	-	
Total switching energy	E_{tot}		-	350	-	
Body Diode Characteristi	ics, <i>T</i> _{vj} = 25°C					
Diode reverse recovery charge	Qrr	$V_{DD} = 800V, I_{SD} = 20A,$ V_{GS} at diode = 0V,	-	0.15	-	μС
Diode peak reverse recovery current	I _{rrm}	$di_f/dt = 1000A/\mu s$, Q_{rr} includes also Q_{c} , see Fig. C	-	8	-	А

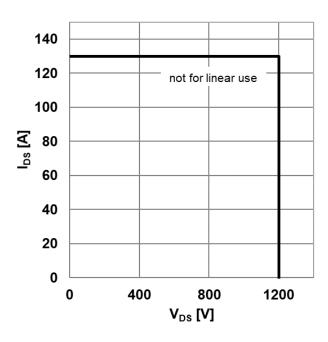
MOSFET Characteristics,	T _{vj} = 175°C	•				
Turn-on delay time	$t_{\sf d(on)}$	$V_{DD} = 800V, I_{D} = 20A,$	-	9	-	
Rise time	t _r	$V_{\rm GS} = 0/15 \text{V}, R_{\rm G,ext} = 2 \Omega,$	-	18	-	
Turn-off delay time	$t_{\sf d(off)}$	L_{σ} = 40nH,	-	20	-	ns
Fall time	t _f	diode:	-	14	-	
Turn-on energy	Eon	body diode at $V_{GS} = 0V$	-	300	-	
Turn-off energy	$E_{ m off}$	see Fig. E	-	75	-	μJ
Total switching energy	$E_{\rm tot}$		-	375	-	
Body Diode Characteristi	cs, <i>T</i> _{vj} = 17	5°C				
Diode reverse recovery charge	Qrr	$V_{DD} = 800 \text{V}, I_{SD} = 20 \text{A},$ V_{GS} at diode = 0V,	-	0.25	-	μС
Diode peak reverse recovery current	I _{rrm}	$di_f/dt = 1000A/μs$, Q_{rr} includes also Q_C , see Fig. C	-	10	-	А

 $^{^4}$ The chip technology was characterized up to 200 kV/ μ s. The measured dV/dt was limited by measurement test setup and package.



Electrical characteristic diagrams

4 Electrical characteristic diagrams



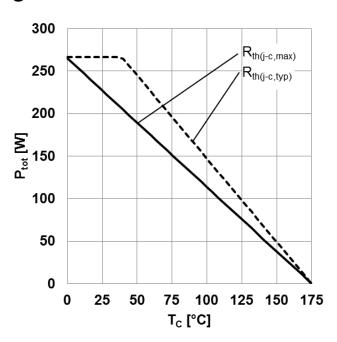
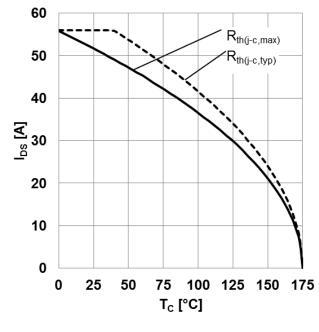


Figure 1 Reverse bias safe operating area (RBSOA) ($V_{gs} = 0/15$ V, $T_c = 25$ °C, $T_j < 175$ °C)

Figure 2 Power dissipation as a function of case temperature limited by bond wire $(P_{tot} = f(T_c))$



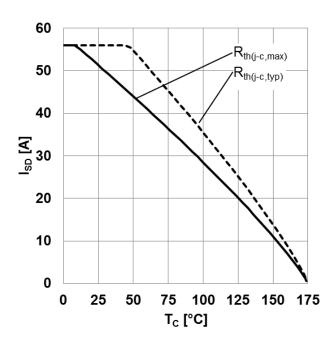
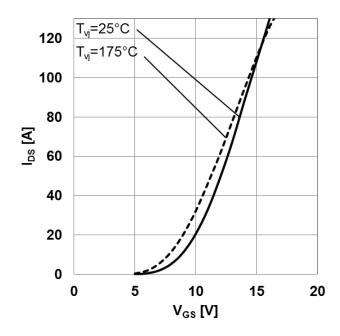


Figure 3 Maximum DC drain to source current as a Figure 4 function of case temperature limited by bond wire $(I_{DS} = f(T_C))$

Maximum source to drain current as a function of case temperature limited by bond wire $(I_{SD} = f(T_C), V_{GS} = 0V)$



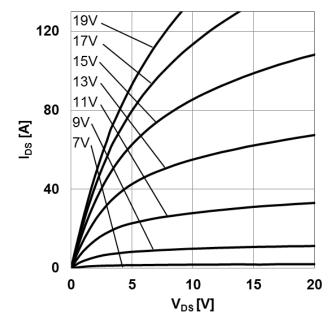
Electrical characteristic diagrams



6
5
4
2
(£)3
2
1
0
-40 0 40 80 120 160
T_{vj} [°C]

Figure 5 Typical transfer characteristic $(I_{DS} = f(V_{GS}), V_{DS} = 20V, t_P = 20\mu s)$

Figure 6 Typical gate-source threshold voltage as a function of junction temperature $(V_{GS(th)} = f(T_{vi}), I_{DS} = 10\text{mA}, V_{GS} = V_{DS})$



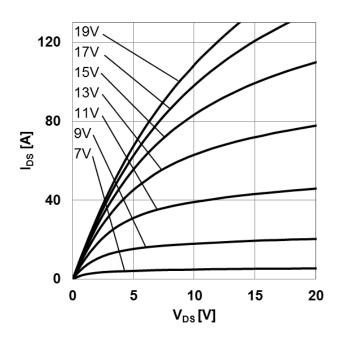


Figure 7 Typical output characteristic, V_{GS} as parameter ($I_{DS} = f(V_{DS})$, $T_{Vj} = 25$ °C, $t_P = 20 \mu s$)

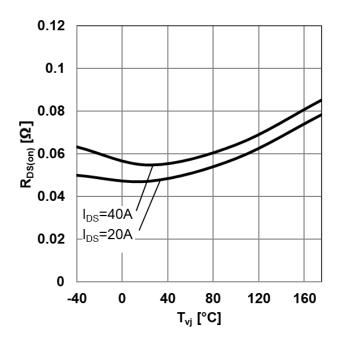
Typical output characteristic, V_{GS} as parameter (I_{DS} = f(V_{DS}), T_{Vj} =175°C, t_P = 20 μ s)

Figure 8

2.6



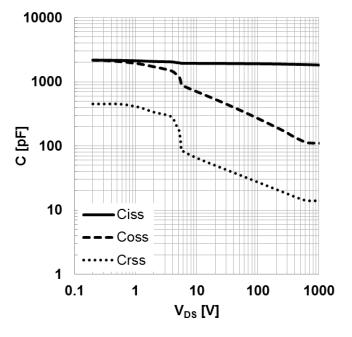
Electrical characteristic diagrams



15 10 $\sum_{\substack{g \\ g \\ 0}}$ 5 0 20 40 60 $Q_{G}[nC]$

Figure 9 Typical on-resistance as a function of junction temperature $(R_{DS(on)} = f(T_{vi}), V_{GS} = 15V)$

Figure 10 Typical gate charge ($V_{GS} = f(Q_G)$, $I_{DS} = 20A$, $V_{DS} = 800V$, turn-on pulse)



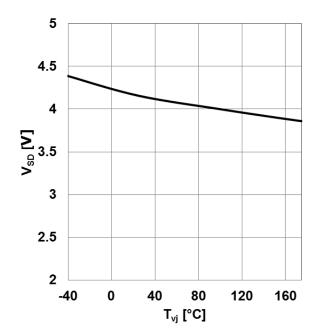


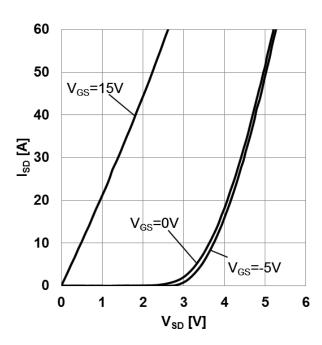
Figure 11 Typical capacitance as a function of drain-source voltage = $f(V_{DS})$, $V_{GS} = 0V$, f = 1MHz)

Figure 12 (C

Typical body diode forward voltage as function of junction temperature $(V_{SD}=f(T_{Vj}), V_{GS}=0V, I_{SD}=20A)$

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Electrical characteristic diagrams



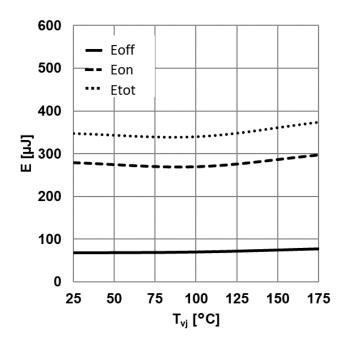
60 50 $V_{GS}=15V$ 40 20 V_{GS}=0V 10 V_{GS} =-5V0 0 1 2 3 4 5 6 V_{SD} [V]

Figure 13 Typical body diode forward current as function of forward voltage, V_{GS} as parameter

$$(I_{SD} = f(V_{SD}), T_{vj} = 25^{\circ}C, t_{P} = 20\mu s)$$

Figure 14 Typical body diode forward current as function of forward voltage, V_{GS} as parameter

$$(I_{SD} = f(V_{SD}), T_{vj} = 175^{\circ}C, t_{P} = 20 \mu s)$$



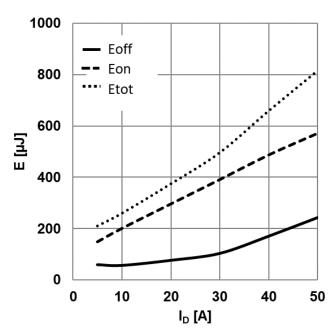


Figure 15 Typical switching energy losses as a function of junction temperature

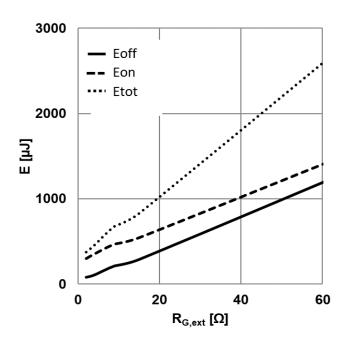
 $(E = f(T_{vj}), V_{DD} = 800V, V_{GS} = 0V/15V,$ $R_{G,ext} = 2\Omega, I_D = 20A, ind. load, test circuit in$ Fig. E, diode: body diode)

Figure 16 Typical switching energy losses as a function of drain-source current

 $(E = f(I_{DS}), V_{DD} = 800V, V_{GS} = 0V/15V,$ $R_{G,ext} = 2\Omega, T_{vj} = 175^{\circ}C$, ind. load, test circuit in Fig. E, diode: body diode)



Electrical characteristic diagrams



150 —td(off)
---tf
---td(on)
---tr

50
0
20
40
60

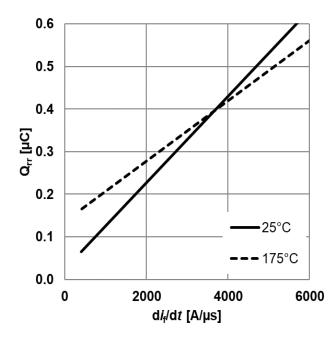
R_{G,ext} [\Omega]

Figure 17 Typical switching energy losses as a function of gate resistance

 $(E = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/15V,$ $I_D = 20A, T_{vj} = 175^{\circ}C$, ind. load, test circuit in Fig. E, diode: body diode)

Figure 18 Typical switching times as a function of gate resistor

 $(t = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/15V, I_D = 20A,$ $T_{vj} = 175$ °C, ind. load, test circuit in Fig. E, diode: body diode)



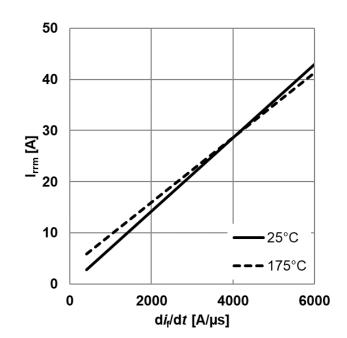


Figure 19 Typical reverse recovery charge as a function of diode current slope

 $(Q_{rr} = f(di_f/dt), V_{DD} = 800V, I_D = 20A, ind. load, test circuit in Fig.E)$

Typical reverse recovery current as a function of diode current slope

 $(I_{rrm} = f(di_f/dt), V_{DD} = 800V, I_D = 20A, ind. load, test circuit in Fig.E)$

Figure 20



Electrical characteristic diagrams

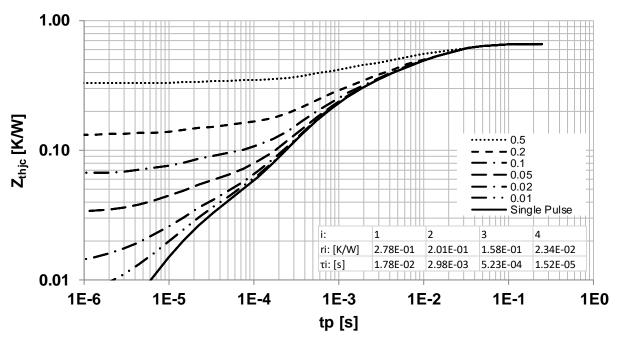


Figure 21 Max. transient thermal resistance (MOSFET/diode)

 $(Z_{\text{th(j-c,max)}} = f(t_P)$, parameter $D = t_P/T$, thermal equivalent circuit in Fig. D)



Package drawing

5 Package drawing

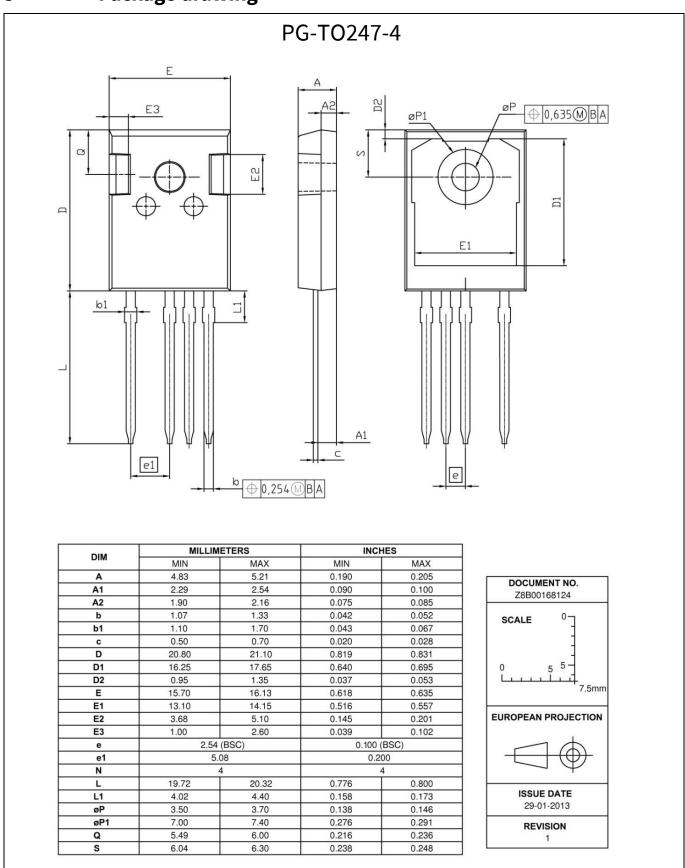


Figure 22 Package drawing

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Test conditions

6 Test conditions

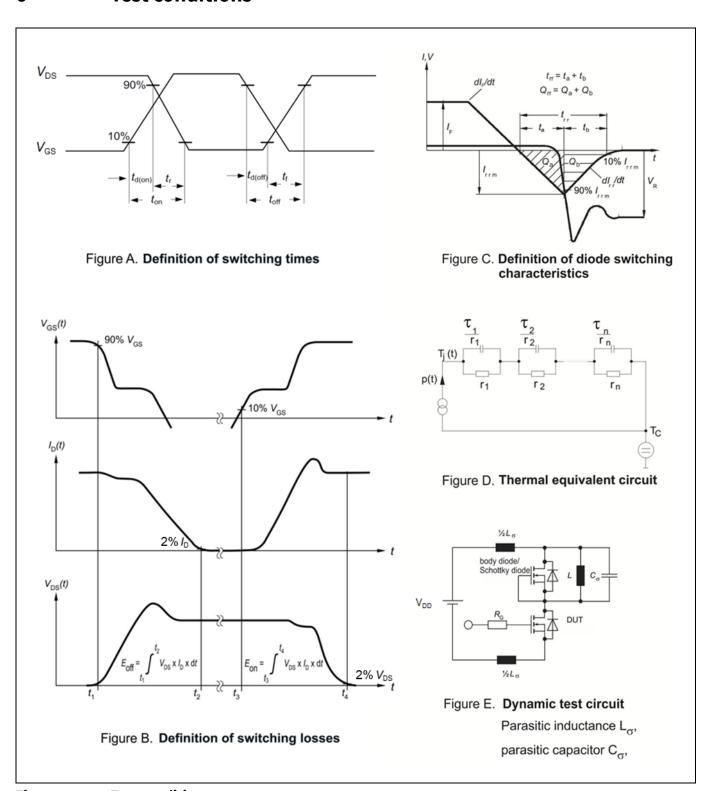


Figure 23 Test conditions

1200V SiC Trench MOSFET



Revision history

Revision history

Major changes since the last revision

Document version	Date of release	Description of changes		
2.1	2018-03-01	Initial version		
2.2	2018-05-30	Important footnote update in chapter 1		
		Change of conditions for switching dynamic characteristics in chapter 3.2 and 3.3		
		Additional figures for V_{GS} =0V/15V in chapter 4		
2.3	2019-04-18	Add Recommended gate voltage in charpter 1		
		Add SOA figure in chapter 4		
		Remove figures for V_{GS} =-5V/15V in chapter 4		
2.4	2019-12-10	Move the short circuit time from dynamic characteristics table 5 to maximum ratings table 2.		
		Update the Figure 21 Zth curve.		
2.5	2020-06-12	Correction of marking letters in table 1		
2.6	2020-12-11	Correction of circuit symbol on page 1		

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